

<b>Notice of References Cited</b>	Application/Control No. 10/608,814	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
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	C	US-6,841,218	01-2005	Hosoda et al.	428/64.1
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	W	English language translation of Mizushima et al.			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	English language translation of Hayashi, Yoshitaka
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